**Fast Charge Battery Manager with Power
DEVICES** Path and IISR Compatibility Path and USB Compatibility

Data Sheet **[ADP5065](http://www.analog.com/ADP5065)**

FEATURES

- **3 MHz switch mode charger**
- **1.25 A charge current from dedicated charger Up to 680 mA charging current from 500 mA USB host Operating input voltage from 4.0 V up to 5.5 V Tolerant input voltage −0.5 V to +20 V (USB VBUS)**
- **Dead battery isolation FET between battery and charger output**
- **Battery thermistor input with automatic charger shutdown for when battery temperature exceeds limits**
- **Compliant with the JEITA Li-Ion battery charging temperature specification**
- **SYS_EN_OK flag to hold off system turn-on until battery is at minimum required level for guaranteed system startup due to minimum battery voltage and/or minimum battery charge level requirements**
- **EOC programming with C/20, C/10 and specific current level selection**

APPLICATIONS

Digital still cameras Digital video cameras Single cell Li-Ion portable equipment PDA, audio, GPS devices Mobile phones

GENERAL DESCRIPTION

The [ADP5065](http://www.analog.com/ADP5065) charger is fully compliant with the USB 2.0, USB 3.0, and USB Battery Charging Specification 1.1 and enables charging via the mini USB VBUS pin from a wall charger, car charger, or USB host port.

The [ADP5065](http://www.analog.com/ADP5065) operates from a 4 V to 5.5 V input voltage range but is tolerant of voltages of up to 20 V. This alleviates the concerns about the USB bus spiking during disconnect or connect scenarios.

The [ADP5065](http://www.analog.com/ADP5065) also features an internal FET between the dc-todc charger output and the battery. This permits battery isolation and, hence, system powering under a dead battery or no battery scenario, which allows for immediate system function on connection to a USB power supply.

FUNCTIONAL BLOCK DIAGRAM

Based on the type of USB source, which is detected by an external USB detection chip, th[e ADP5065](http://www.analog.com/ADP5065) can be set to apply the correct current limit for optimal charging and USB compliance.

The [ADP5065](http://www.analog.com/ADP5065) comes in a very small and low profile 20-lead WLCSP (0.5 mm pitch spacing) package.

The overall solution requires only five small, low profile external components consisting of four ceramic capacitors (one of which is the battery filter capacitor), one multilayer inductor. In addition to these components, there is one optional dead battery situation default setting resistor. This configuration enables a very small PCB area to provide an integrated and performance enhancing solution to USB battery charging and power rail provision.

Rev. D [Document Feedback](https://form.analog.com/Form_Pages/feedback/documentfeedback.aspx?doc=%20ADP5065.pdf&product=ADP5065&rev=D)

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REVISION HISTORY

2/13—Rev. C to Rev. D

9/12—Rev. B to Rev. C

4/12—Rev. A to Rev. B

10/11—Revision 0: Initial Version

SPECIFICATIONS

 $-40^{\circ}\text{C} < T_J < 125^{\circ}\text{C}$, $V_{\text{IN}} = 5.0$ V, $V_{\text{ISO_S}} > 3.0$ V, $V_{\text{HOT}} < V_{\text{THR}} < V_{\text{COLD}}$, $V_{\text{BAT_SNS}} = 3.6$ V, $C_{\text{VIN}} = 2.2$ µF, $C_{\text{DOC}} = 22$ µF, $C_{\text{BAT}} = 22$ µF, $C_{\text{CHLT}} = 22$ 4.7μ F, $\text{L}_{\text{OUT}} = 1 \mu$ H, all registers are at default values, unless otherwise noted.

Table 1.

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¹ These values are programmable via I²C. Values are given with default register values.

² The output current during charging can be limited by I_{BUS} or by the isothermal charging mode.

³ Programmable via external resistor programming, if required.
⁴ JEITA can be enabled or disabled in I²C.

RECOMMENDED INPUT AND OUTPUT CAPACITANCE

Table 2.

I ²C-COMPATIBLE INTERFACE TIMING SPECIFICATIONS

Table 3.

¹ Guaranteed by design.

² A master device must provide a hold time of at least 300 ns for the SDA signal to bridge the undefined region of the falling edge of SCL. Se[e Figure 2,](#page-5-1) the I²C timing diagram.

Timing Diagram

Figure 2. I²C Timing Diagram

ABSOLUTE MAXIMUM RATINGS

Table 4.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

 $θ_{JA}$ is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

Table 5. Thermal Resistance

 15×4 array, 0.5 mm pitch (2.75 mm \times 2.08 mm); based on a JEDEC, 2S2P, 4-layer board with 0 m/sec airflow.

Maximum Power Dissipation

The maximum safe power dissipation in th[e ADP5065](http://www.analog.com/ADP5065) package is limited by the associated rise in junction temperature (T_J) on the die. At approximately 150°C, which is the glass transition temperature, the plastic changes its properties. Even temporarily exceeding this temperature limit may change the stresses that the package exerts on the die, permanently shifting the parametric performance of the [ADP5065.](http://www.analog.com/ADP5065) Exceeding a junction temperature of 175°C for an extended period of time can result in changes in the silicon devices that potentially cause failure.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

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1 I is input, O is output, I/O is input/output, and G is ground.

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Figure 23. Mode Change, Fast Charge to Suspend (EN_CHG from High to Low), ILIM = 500 mA, R_{LOAD} = 33 Ω

 $EN_CHG = High, V_{IN} = 5.0 V, R_{LOAD} = 33 \Omega$

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THEORY OF OPERATION **INTRODUCTION**

The $ADP5065$ is a fully I²C-programmable charger for singlecell lithium-ion or lithium-polymer batteries suitable for a wide range of portable applications.

The highly efficient switcher dc-to-dc architecture enables higher charging currents as well as a lower temperature charging operation that results in faster charging times because of the following features:

- 3 MHz switch mode charger.
- 1.25 A charge current from dedicated charger.
- Up to 680 mA of charging current from a 500 mA USB host.

The [ADP5065](http://www.analog.com/ADP5065) operates from an input voltage from 4 V to 5.5 V but is tolerant of voltages of up to 20 V. This alleviates the concern about USB bus spiking during disconnection or connection scenarios.

The [ADP5065](http://www.analog.com/ADP5065) features an internal FET between the dc-to-dc charger output and the battery. This permits battery isolation and, hence, system powering in a dead battery or no battery scenario, which allows for immediate system function on connection to a USB power supply.

Th[e ADP5065](http://www.analog.com/ADP5065) is fully compliant with the USB 3.0 battery charging specification and enables charging via the mini USB VBUS pin from a wall charger, car charger, or USB host port. Based on the type of USB source, which is detected by an external USB detection device, th[e ADP5065](http://www.analog.com/ADP5065) can be set to apply the correct current limit for optimal charging and USB compliance. The USB charger permits correct operation under all USB compliant sources such as, wall chargers, host chargers, hub chargers, and standard hosts and hubs.

A processor is able to control the USB charger using the $I²C$ to program the charging current and numerous other parameters including

- Trickle charge current level.
- Trickle charge voltage threshold.
- Weak charge (constant current) charge current level.
- Fast charge (constant current) charge current level.
- Fast charge (constant voltage) charge voltage level at 1% accuracy.
- Fast charge safety timer period.
- Watchdog safety timer parameters.
- Weak battery threshold detection.
- Charge complete threshold.
- Recharge threshold.
- Charge enable/disable.
- Battery pack temperature detection and automatic charger shutdown.

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The [ADP5065](http://www.analog.com/ADP5065) also includes a number of significant features to optimize charging and functionality, including

- Thermal regulation for maximum performance.
- USB host current-limit accuracy: ±5 %.
- Termination voltage accuracy: ± 1 %.
- Battery thermistor input with automatic charger shutdown in the event that the battery temperature exceeds limits. (Compliant with the JEITA Li-Ion battery charging temperature specification.)
- Offloads processor to manage external pin (TRK_EXT) control to enable/disable trickle charging.
- Direct external pin (IIN_EXT) control of 100 mA or 500 mA input current limit.
- Optional external resistor programming input, V_WEAK_ SET, which is used for setting the $V_{\rm WEAK}$ threshold. When the battery reaches the V_{WEAK} threshold, the [ADP5065](http://www.analog.com/ADP5065) pulls down the SYS_EN_OK open-drain output flag. The flag can be used to hold off system turn on until the battery is at the minimum required level for a guaranteed system startup.

CHARGER MODES

Input Current Limit

The VINx input current limit is controlled via an internal I²C ILIM register. The input current limit can also be controlled via the IIN_EXT pin as outlined i[n Table 7.](#page-16-1) Any change in the I²C default from 100 mA dominates over the pin setting.

Table 7. IIN_EXT Operation

USB Compatibility

The [ADP5065](http://www.analog.com/ADP5065) charger provides support for the following connections through the single connector VINx pin.

The [ADP5065](http://www.analog.com/ADP5065) features a programmable input current limit to ensure compatibility with the requirements listed in [Table 8.](#page-16-2) The current limit defaults to 100 mA to allow compatibility with a USB host or hub that is not configured.

The I ²C register default is 100 mA. An I ²C write command to the ILIM register overrides the IIN_EXT pin and the I ²C register default value can be reprogrammed for alternative requirements.

When the input current limiting feature is used, the available input current may be too low for the charger to meet the programmed charging current, ICHG, and the rate of charge is reduced. In this case, the VIN_ILIM flag is set.

When connecting voltage to VINx without having the proper voltage level on the battery side, the HV blocking part is in a state wherein it draws only 1.3 mA (typical) of current until the V_{IN} has reached the VIN_OK level.

Trickle Charge Mode

A deeply discharged Li-Ion cell may exhibit a very low cell voltage making it unsafe to charge the cell at high current rates. The [ADP5065](http://www.analog.com/ADP5065) charger uses a trickle charge mode to reset the battery pack protection circuit and lift the cell voltage to a safe level for fast charging. A cell with a voltage below VTRK_DEAD is charged with the trickle mode current, ITRK_DEAD. During trickle charging mode, the CHARGER_STATUS register is set.

During trickle charging, the ISO_Sx node is regulated to VISO_STRK by the dc-to-dc converter and the battery isolation FET is off, which means the battery is isolated from the system power supply.

Trickle charging can be controlled via the TRK_EXT external pin (see [Table 9\)](#page-16-3). Note that any change in the I²C EN_TRK bit dominates over the pin setting.

Table 9. TRK_EXT Operation

Trickle Charge Mode Timer

The duration of trickle charge mode is monitored to ensure the battery is revived from its deeply discharged state. If trickle charge mode runs for longer than 60 minutes without the cell voltage reaching V_{TRK_DEAD}, a fault condition is assumed and charging stops. The fault condition is asserted on the CHARGER_STATUS register, allowing the user to initiate the fault recovery procedure specified in the [Fault Recovery](#page-18-2) section.

Weak Charge Mode (Constant Current)

When the battery voltage exceeds VTRK_DEAD but is less than VWEAK, the charger switches to the intermediate charge mode.

During the weak charge mode, the battery voltage is too low to allow the full system to power-up. Due to the low level of the battery, the USB transceiver cannot be powered and, therefore, cannot enumerate for more current from a USB host. Consequently, the USB limit remains at 100 mA.

The system microcontroller may or may not be powered by the charger output voltage (V_{ISO_SFC}) depending upon the amount of current required by the microcontroller and/or the system architecture. In this case, the battery charge current ($I_{CHG~WEAK}$) cannot be increased above 20 mA to ensure the microcontroller can still operate (if doing so) nor increased above the 100 mA USB limit. Thus, set the battery charging current as follows:

- Set the default 20 mA via the linear trickle charger branch (to ensure that the microprocessor remains alive if powered by the main switching charger output, ISO_Sx). Any residual current on the main switching charger output, ISO_Sx, is used to charge the battery at up to the preprogrammed level in the I²C for I_{CHG} (fast charge current limit) or I_{LIM} (input current limit).
- During weak current mode, other features may prevent the actual programmed weak charging current from reaching its full programmed value. Isothermal charging mode or input current limiting for USB compatibility may affect the programmed weak charging current value under certain operating conditions. During weak charging, the ISO_Sx node is regulated to V_{ISO_SFC} by the battery isolation FET.

Fast Charge Mode (Constant Current)

When the battery voltage exceeds $V_{TRK\ DEAD}$ and V_{WEAK} , the charger switches to fast charge mode, charging the battery with the constant current, I_{CHG}. During fast charge mode (constant current), the CHARGER_STATUS register is set.

During constant current mode, other features may prevent the current, ICHG, from reaching its full programmed value. Isothermal charging mode or input current limiting for USB compatibility may affect the value of I_{CHG} under certain operating conditions. The voltage on ISO_Sx is regulated to stay at V_{ISO_SFC} by the battery isolation FET when $V_{ISO_B} < V_{ISO_SFC}$.

Fast Charge Mode (Constant Voltage)

As the battery charges, its voltage rises and approaches the termination voltage, V_{TRM} . Th[e ADP5065](http://www.analog.com/ADP5065) charger monitors the voltage on the BAT_SNS pin to determine when charging should end. However, the internal ESR of the battery pack combined with PCB and other parasitic series resistances creates a voltage drop between the sense point at the BAT_SNS pin and the cell terminal itself. To compensate for this and ensure a fully charged cell, the [ADP5065](http://www.analog.com/ADP5065) enters a constant voltage charging mode when the termination voltage is detected on the BAT_SNS pin. The [ADP5065](http://www.analog.com/ADP5065) reduces charge current gradually as the cell continues to charge, maintaining a voltage of V_{TRM} on the BAT_SNS pin. During fast charge mode (constant voltage), the CHARGER_ STATUS register is set.

Fast Charge Mode Timer

The duration of fast charge mode is monitored to ensure that the battery is charging correctly. If the fast charge mode runs for longer than t_{CHG} without the voltage at the BAT_SNS pin reaching V_{TRM}, a fault condition is assumed and charging stops. The fault condition is asserted on the CHARGER_STATUS register allowing the user to initiate the fault recovery procedure specified in the [Fault Recovery](#page-18-2) section.

If the fast charge mode runs for longer than t_{CHG} , and V_{TRM} has been reached on the BAT_SNS pin but the charge current has not yet fallen below IEND, charging stops. No fault condition is asserted in this circumstance and charging resumes as normal if the recharge threshold is breached.

Watchdog Timer

The [ADP5065](http://www.analog.com/ADP5065) charger features a programmable watchdog timer function to ensure charging is under the control of the processor. The watchdog timer starts running when the [ADP5065](http://www.analog.com/ADP5065) charger determines that the processor should be operational, that is, when the processor sets the RESET_WD bit for the first time or when the battery voltage is greater than the weak battery threshold, V_{WEAK}. When the watchdog timer has been triggered, it must be reset regularly within the watchdog timer period, twp.

If the watchdog timer expires without being reset while in charger mode, th[e ADP5065](http://www.analog.com/ADP5065) charger assumes there is a software problem and triggers the safety timer, tsAFE. For more information see the [Safety Timer](#page-18-3) section.

Safety Timer

If the watchdog timer (see th[e Watchdog Timer](#page-17-0) section for more information) expires while in charger mode, th[e ADP5065](http://www.analog.com/ADP5065) charger initiates the safety timer, t_{SAFE}. If the processor has programmed charging parameters by this time, the ILIM is set to the default value. Charging continues for a period of t_{SAFE}, then the charger switches off and sets the CHARGER_STATUS register.

Charge Complete

The [ADP5065](http://www.analog.com/ADP5065) charger monitors the charging current while in constant voltage fast charge mode. If the current falls below I_{END} and remains below I_{END} for t_{END} , charging stops and the CHDONE flag is set. If the charging current falls below I_{END} for less than t_{END} and then rises above I_{END} again, the t_{END} timer resets.

Recharge

After the detection of charge complete, and the cessation of charging, th[e ADP5065 c](http://www.analog.com/ADP5065)harger monitors the BAT_SNS pin as the battery discharges through normal use. If the BAT_SNS pin voltage falls to V_{RCH} , the charger reactivates charging. Under most circumstances, triggering the recharge threshold results in the charger starting directly into fast charge constant voltage mode.

Battery Charging Enable/Disable

The [ADP5065](http://www.analog.com/ADP5065) charging function can be disabled by setting the I ²C EN_CHG bit to low.

THERMAL MANAGEMENT

Isothermal Charging

To assist with the thermal management of th[e ADP5065](http://www.analog.com/ADP5065) charger, the battery charger provides an isothermal charging function. As the on-chip power dissipation and die temperature increase, the [ADP5065](http://www.analog.com/ADP5065) charger monitors die temperature and limits output current when the temperature reaches TLIM (typically at 115°C). The die temperature is maintained at T_{LIM} through the control of the charging current into the battery. A reduction in power dissipation or ambient temperature may allow the charging current to return to its original value, and the die temperature subsequently drops below T_{LIM}. During isothermal charging, the THERM_LIM flag is set to high.

Thermal Shutdown and Thermal Early Warning

The [ADP5065](http://www.analog.com/ADP5065) switching charger features a thermal shutdown threshold detector. If the die temperature exceeds T_{SD} , the [ADP5065](http://www.analog.com/ADP5065) charger is disabled, and the TSD 140°C bit is set. The [ADP5065](http://www.analog.com/ADP5065) charger can be reenabled when the die temperature drops below the T_{SD} falling limit and the TSD 140°C bit is reset. To reset the TSD 140°C bit, write to the I²C Fault Register 0x0D or cycle the power.

Before die temperature reaches T_{SD} , the early warning bit is set if T_{SDL} is exceeded. This allows the system to accommodate power consumption before thermal shutdown occurs.

Fault Recovery

Before performing the following operation, it is important to ensure that the cause of the fault has been rectified.

To recover from a charger fault (when the CHARGER_STATUS equals 110), cycle power on VINx or write high to reset the I ²C fault bits in the fault register.

BATTERY ISOLATION FET

The [ADP5065](http://www.analog.com/ADP5065) charger features an integrated battery isolation FET for power path control. The battery isolation FET isolates a deeply discharged Li-Ion cell from the system power supply in both trickle and fast charge modes, thereby allowing the system to be powered at all times.

When VINx is below V_{VIN_OK} , the battery isolation FET is in full conducting mode.

The battery isolation FET is off during trickle charge mode. When the battery voltage exceeds V_{TRK} , the battery isolation FET switches to the system voltage regulation mode. During system voltage regulation mode, the battery isolation FET maintains the V_{ISO_SFC} voltage on the ISO_Sx pins. When the battery voltage exceeds V_{ISO_SFC}, the battery isolation FET is in full conducting mode.

The battery isolation FET supplements the battery to support high current functions on the system power supply.

When voltage on ISO_Sx drops below ISO_Bx, the battery isolation FET enters into full conducting mode.

When voltage on ISO_Sx rises above ISO_Bx, the isolation FET enters regulating mode or full conduction mode, depending on the Li-Ion cell voltage and the dc-to-dc charger mode.

BATTERY DETECTION

Battery Level Detection

The [ADP5065](http://www.analog.com/ADP5065) charger features a battery detection mechanism to detect an absent battery. The charger actively sinks and sources current into the ISO_Bx/BAT_SNS node, and voltage vs. time is detected. The sink phase is used to detect a charged battery, whereas the source phase is used to detect a discharged battery.

The sink phase (se[e Figure 32\)](#page-19-1) sinks I_{SINK} current from the ISO_Bx/ BAT_SNS pins for a time, tBATOK. If the BAT_SNS pin is below V_{BATL} when the t_{BATOK} timer expires, the charger assumes no battery is present, and starts the source phase. If the BAT_SNS exceeds the V_{BATL} voltage when the t_{BATOK} timer expires, the charger assumes the battery is present, and begins a new charge cycle.

The source phase sources ISOURCE current to ISO_Bx or the BAT_SNS pins for a time, t_{BATOK}. If the BAT_SNS pin exceeds VBATH before the tBATOK timer expires, the charger assumes that no battery is present. If the BAT_SNS does not exceed the VBATH voltage when the t_{BATOK} timer expires, the charger assumes that a battery is present, and begins a new charge cycle.

Battery (ISO_Bx) Short Detection

A battery short occurs under a damaged battery condition or when the battery protection circuitry is enabled.

On commencing trickle charging, th[e ADP5065 c](http://www.analog.com/ADP5065)harger monitors the battery voltage. If this battery voltage does not exceed VBAT_SHR within the specified timeout period, tBAT_SHR, a fault is declared and the charger is stopped by turning the battery isolation FET off but the system voltage is maintained at VISO_STRK by the linear regulator.

The trickle charge branch is active during the battery short scenario, and trickle charge current to the battery is maintained until the 60 minute trickle charge mode timer expires.

After source phase, if the ISO_Bx or BAT_SNS level remains below V_{BATH}, either the battery voltage is low or the battery node can be shorted. As a result of the battery voltage being low, trickle charging mode is initiated (se[e Figure 33\)](#page-19-2). If the BAT_SNS level remains below VBAT_SHR after tBAT_SHR has elapsed, th[e ADP5065](http://www.analog.com/ADP5065) assumes that the battery node is shorted.

BATTERY PACK TEMPERATURE SENSING

Battery Thermistor Input

The [ADP5065](http://www.analog.com/ADP5065) charger features battery pack temperature sensing that precludes charging when the battery pack temperature is outside the specified range. The THR pin provides an on and off switching current source, which should be connected directly to the battery pack thermistor terminal. The activation interval of the THR current source is 167 ms.

The battery pack temperature sensing can be controlled by I ²C using the conditions shown i[n Table 10.](#page-20-1) Note that the I ²C register default setting for EN_THR (Register 0x07) is $0 =$ temperature sensing off.

Table 10. THR Input Function

If the battery pack thermistor is not connected directly to the [ADP5065](http://www.analog.com/ADP5065) THR pin, a 10 kΩ (tolerance ±20%) dummy resistor must be connected between the THR input and GND. Leaving the THR pin open results in a false detection of the battery temperature being <0°C and charging is disabled.

The [ADP5065](http://www.analog.com/ADP5065) charger monitors the voltage in the THR pin and suspends charging if the current is outside the range of less than 0°C or greater than 60°C. For temperatures greater than 0°C, the THR_STATUS register is set accordingly, and for temperatures lower than 60°C, the THR_STATUS register is, likewise, set accordingly.

Th[e ADP5065](http://www.analog.com/ADP5065) charger is designed for use with an NTC thermistor in the battery pack with a nominal room temperature value of either 10 kΩ at 25°C or 100 kΩ at 25°C, which is selected by a fuse.

Th[e ADP5065](http://www.analog.com/ADP5065) charger is designed for use with an NTC thermistor in the battery pack with a temperature coefficient curve (beta). Fuse-selectable beta programming is supported by eight steps covering a range from 3150 to 4400 (see [Table 34\)](#page-36-1).

JEITA Li-Ion Battery Temperature Charging Specification

The [ADP5065](http://www.analog.com/ADP5065) is compliant with the JEITA Li-Ion battery charging temperature specifications as outlined in [Table 11.](#page-20-2)

The JEITA function can be enabled via the I²C interface. When the [ADP5065](http://www.analog.com/ADP5065) detects a JEITA cool condition, charging current is reduced according t[o Table 12.](#page-20-3)

When th[e ADP5065](http://www.analog.com/ADP5065) identifies a hot or cold battery condition, the [ADP5065](http://www.analog.com/ADP5065) takes the following actions:

- Stops charging the battery.
- Connects/enables the battery isolation FET such that the system power supply node is connected to the battery.

Table 11. JEITA Li-Ion Battery Charging Specification Defaults

Table 12. JEITA Reduced Charge Current Levels

EXTERNAL RESISTOR FOR V_WEAK_SET

The [ADP5065](http://www.analog.com/ADP5065) charger features a V_{WEAK} threshold, which can be used for enabling the main PMU system. When battery voltage at the BAT_SNS pin exceeds the V_{WEAK} level, the [ADP5065](http://www.analog.com/ADP5065) pulls down the SYS_ON_OK open-drain flag.

The V_{WEAK} threshold can be programmed set either by I²C or by an external resistor connected between the V_WEAK_SET pin and GND. Recommended resistor values for each threshold are listed i[n Table 13.](#page-21-1)

If an external resistor is not used, it is recommended to tie the V_WEAK_SET pin to AGND for V_{WEAK} to obtain its default value.

Table 13. Resistor Values for V_WEAK_SET Pin

I ²C INTERFACE

The [ADP5065](http://www.analog.com/ADP5065) includes an I²C-compatible serial interface for control of the charging and for a readback of system status registers. The I²C chip address is 0x28 in write mode and 0x29 in read mode.

Register values are reset to the default values, when the supply voltage at the VINx pin falls below the V_{VIN_OK} falling voltage threshold. The I²C registers are also reset when the battery is disconnected and V_{IN} is 0 V.

Se[e Figure 34 f](#page-22-1)or an example of the I^2C write sequence to a single register. The subaddress content selects which one of the five [ADP5065](http://www.analog.com/ADP5065) registers is written to first. The [ADP5065](http://www.analog.com/ADP5065) sends an acknowledgement to the master after the 8-bit data byte has been written. Th[e ADP5065 i](http://www.analog.com/ADP5065)ncrements the subaddress automatically and starts receiving a data byte to the following register until the master sends an I²C stop as shown in Figure 35.

[Figure 36 s](#page-22-3)hows the I²C read sequence of a single register. [ADP5065](http://www.analog.com/ADP5065) sends the data from the register denoted by the subaddress and increments the subaddress automatically, sending data from the next register until the master sends an I ²C stop condition as shown in [Figure 37.](#page-22-4)

CHARGER OPERATIONAL FLOWCHART

Figure 38[. ADP5065](http://www.analog.com/ADP5065) Operational Flowchart

I ²C REGISTER MAP

Table 14. I ²C Register Map¹

1 Each blank cell indicates a bit that is not used.

REGISTER BIT DESCRIPTIONS

Table 16. Silicon Revision, Register Address 0x01 Bit Descriptions

Table 17. VINx Settings, Register Address 0x02 Bit Descriptions

Data Sheet **ADP5065**

Table 20. Voltage Threshold, Register Address 0x05 Bit Descriptions

Data Sheet **ADP5065**

Table 22. Functional Settings1, Register Address 0x07 Bit Descriptions

Table 23. Functional Settings2, Register Address 0x08 Bit Descriptions

Table 24. Interrupt Enable, Register Address 0x09 Bit Descriptions

Table 25. Interrupt Active, Register Address 0x0A Bit Descriptions

Table 26. Charger Status 1, Register Address 0x0B Bit Descriptions

Table 27. Charger Status Register 2, Register Address 0x0C Bit Descriptions

' To reset the fault bits in the fault register, cycle power on VINx or write high to the corresponding I'C bit.

Table 29. Battery Short, Register Address 0x10 Bit Descriptions

APPLICATIONS INFORMATION **EXTERNAL COMPONENTS**

Inductor Selection

The high switching frequency of the [ADP5065](http://www.analog.com/ADP5065) buck converter allows for the selection of small chip inductors. Suggested inductors are shown in [Table 33.](#page-32-0)

The peak-to-peak inductor current ripple is calculated using the following equation:

$$
I_{RIPPLE} = \frac{V_{OUT} \times (V_{IN} - V_{OUT})}{V_{IN} \times f_{SW} \times L}
$$

where:

 V_{OUT} is the ISO Sx node output voltage. V_{IN} is the converter input voltage at the CFILT node. f_{SW} is the switching frequency. L is the inductor value.

The minimum dc current rating of the inductor must be greater than the inductor peak current. The inductor peak current is calculated using the following equation:

$$
I_{\it PEAK} = I_{\it CHG} + I_{\it LOAD(MAX)} + \frac{I_{\it RIPPLE}}{2}
$$

Inductor conduction losses are caused by the flow of current through the inductor, which has an associated internal dc resistance (DCR). Larger sized inductors have smaller DCR, which may decrease inductor conduction losses. Inductor core losses are related to the magnetic permeability of the core material. Because the bucks are high switching frequency dc-to-dc converters, shielded ferrite core material is recommended for its low core losses and low EMI.

ISO_Sx (VOUT) and ISO_Bx Capacitor Selection

To safely obtain stable operation of the [ADP5065,](http://www.analog.com/ADP5065) the ISO_Sx and ISO_Bx effective capacitance (including temperature and dc bias effects) must not be less than 10 µF at any point during operation. The combined effective capacitance of the ISO_Sx capacitor and the system capacitance must not exceed 50 µF at any point during operation.

Higher output capacitor values reduce the output voltage ripple and improve load transient response. When choosing this value, it is also important to account for the loss of capacitance due to output voltage dc bias.

Ceramic capacitors are manufactured with a variety of dielectrics, each with a different behavior over temperature and applied voltage. Capacitors must have a dielectric adequate enough to ensure the minimum capacitance over the necessary temperature range and dc bias conditions. X5R or X7R dielectrics with a voltage rating of 6.3 V or 10 V are recommended for best performance. Y5V and Z5U dielectrics are not recommended for use with any dc-to-dc converter because of their poor temperature and dc bias characteristics.

The worst-case capacitance accounting for capacitor variation over temperature, component tolerance, and voltage is calculated using the following equation:

$$
C_{EFF} = C_{OUT} \times (1 - TEMPCO) \times (1 - TOL)
$$

where:

 C_{EFF} is the effective capacitance at the operating voltage. TEMPCO is the worst-case capacitor temperature coefficient. TOL is the worst-case component tolerance.

In this example, the worst-case temperature coefficient (TEMPCO) over −40°C to +85°C is assumed to be 15% for an X5R dielectric. The tolerance of the capacitor (TOL) is assumed to be 10%, and C_{OUT} is 16 μ F at 4.2 V, as shown i[n Figure 39.](#page-31-2)

Substituting these values in the equation yields

 $C_{EFF} = 16 \mu F \times (1 - 0.15) \times (1 - 0.1) \approx 12.24 \mu F$

Figure 39. Murata GRM31CR60J226ME19C DC Characteristic

To guarantee the performance of the charger in various operation modes including trickle charge, constant current charge, and constant voltage charge, it is imperative that the effects of dc bias, temperature, and tolerances on the behavior of the capacitors be evaluated for each application.

The peak-to-peak output voltage ripple for the selected output capacitor and inductor values is calculated using the following equation:

$$
V_{RIPPLE} = \frac{I_{RIPPLE}}{8 \times f_{SW} \times C_{OUT}} \approx \frac{V_{IN}}{(2\pi \times f_{SW})^2 \times L \times C_{OUT}}
$$

Capacitors with lower effective series resistance (ESR) are preferable to guarantee low output voltage ripple, as shown in the following equation:

$$
ESR_{COUT} \leq \frac{V_{RIPPLE}}{I_{RIPPLE}}
$$

VINx Capacitor Selection

According to the USB 2.0 specification, USB peripherals have a detectable change in capacitance on VBUS when they are attached. The peripheral device VBUS bypass capacitance must be at least 1 µF but not larger than 10 µF. The combined capacitance for the VINx and CFILT pins must not exceed 10 µF at any temperature or dc bias condition. Suggestions for a VINx capacitor is given i[n Table 32.](#page-32-1)

CFILT Capacitor Selection

CFILT pin serves th[e ADP5065](http://www.analog.com/ADP5065) as the step-down dc-to-dc converter input capacitor. Maximum input capacitor current is calculated using the following equation:

$$
I_{\textit{CIN}} \geq I_{\textit{LOAD}+\textit{CHG(MAX)}}\sqrt{\frac{V_{\textit{ISO_S}}(V_{\textit{CHLT}}-V_{\textit{ISO_S}})}{V_{\textit{CHLT}}}}
$$

To minimize supply noise, place the input capacitor as close as possible to the CFILT pin of the charger. As with the output capacitor, a low ESR capacitor is recommended.

The effective capacitance needed for stability, which includes temperature and dc bias effects, is a minimum of 2μ F and a maximum of 5 µF. A list of suggested capacitors is shown in [Table 31.](#page-32-2)

Table 30. ISO_Sx and ISO_Bx Capacitor Suggestions

Table 31. CFILT Capacitor Suggestions

Table 32. VINx Capacitor Suggestions

Table 33. 1.0 µH Inductor Suggestions

PCB LAYOUT GUIDELINES

Poor layout can affec[t ADP5065 p](http://www.analog.com/ADP5065)erformance, causing electromagnetic interference (EMI) and electromagnetic compatibility (EMC) problems, ground bounce, and voltage losses. Poor layout can also affect regulation and stability. A good layout is implemented using the following guidelines:

- Place the inductor, input capacitor, and output capacitor close to the IC using short tracks. These components carry high switching frequencies, and large tracks act as antennas.
- Route the output voltage path away from both the inductor and SWxnode to minimize noise and magnetic interference.
- Maximize the size of ground metal on the component side to help with thermal dissipation.
- Use a ground plane with several vias connecting to the component side ground to further reduce noise interference on sensitive circuit nodes.

POWER DISSIPATION AND THERMAL CONSIDERATIONS

The [ADP5065](http://www.analog.com/ADP5065) is a highly efficient USB compliant charger. However, if the device operates at high ambient temperatures and maximum current charging and loading conditions, the junction temperature can reach the maximum allowable operating limit (125°C).

When the temperature exceeds 140°C, th[e ADP5065](http://www.analog.com/ADP5065) turns off allowing the device to cool down. When the die temperature falls below 110°C and the TSD 140°C fault bit in Register 0x0D is cleared by an I²C write, the [ADP5065](http://www.analog.com/ADP5065) resumes normal operation.

This section provides guidelines to calculate the power dissipated in the device and ensure that th[e ADP5065](http://www.analog.com/ADP5065) operates below the maximum allowable junction temperature.

The output power of the [ADP5065](http://www.analog.com/ADP5065) charger is gived by

$$
P_{OUT} = V_{ISO_S} \times I_{LOAD} + V_{ISO_B} \times I_{CHG}
$$
 (1)

where:

 P_{OUT} is the total output power to the system and battery. V_{ISO_S} is the ISO_Sx pin voltage. I_{LOAD} is the load current from ISO $\,$ Sx node. V_{ISO_B} is the battery voltage. I_{CHG} is the charge current.

The efficiency of the [ADP5065](http://www.analog.com/ADP5065) is given by

$$
\eta = \frac{P_{OUT}}{P_{IN}} \times 100\%
$$
\n(2)

where:

 η is the efficiency. P_{IN} is the input power.

Power loss is given by

$$
P_{LOSS} = P_{IN} - P_{OUT} \tag{3a}
$$

or

$$
P_{\text{LOSS}} = P_{\text{OUT}} \left(1 - \eta \right) / \eta \tag{3b}
$$

Power dissipation can be calculated in several ways. The most intuitive and practical is to measure the power dissipated at the input and both outputs (ISO_Sx and ISO_Bx). Perform the measurements at the worst-case conditions (voltages, currents, and temperature). The difference between input and output power is dissipated in the device and the inductor. Use Equation 5 to derive the power lost in the inductor and, from this, use Equation 4 to calculate the power dissipation in the [ADP5065](http://www.analog.com/ADP5065) charger.

A second method to estimate the power dissipation uses the system voltage and charging efficiency curves provided for the [ADP5065.](http://www.analog.com/ADP5065) When the efficiency is known, use Equation 3b to derive the total power lost in the dc-to-dc converter, isolation FET and inductor; use Equation 5 to derive the power lost in the inductor, and then calculate the power dissipation in the buck converter using Equation 4.

Note that the [ADP5065](http://www.analog.com/ADP5065) efficiency curves are typical values and may not be provided for all possible combinations of V_{IN} , V_{OUT} , and I_{OUT.} To account for these variations, it is necessary to include a safety margin when calculating the power dissipated in the charger.

CHARGER POWER DISSIPATION

The power loss of the step-down charger is approximated by

$$
P_{LOSS} = P_{DCHG} + P_L \tag{4}
$$

where:

 P_{DCHG} is the power dissipation of th[e ADP5065](http://www.analog.com/ADP5065) charger. P_L is the inductor power losses.

The inductor losses are external to the device, and they do not have any effect on the die temperature. Equation 5 estimates the inductor losses without core losses. Some inductor manufacturers provide web tools to estimate power inductor core losses based on inductor type, switching frequency, and ripple current. At a switching frequency of 3 MHz, the core losses can add inductor losses significantly.

$$
P_L \approx I_{OUT(RMS)}^2 \times DCR_L \tag{5}
$$

where:

DCR^L is the inductor series resistance.

 $I_{OUT(RMS)}$ is the summary of rms load current and charging current $(I_{LOAD(RMS)} + I_{CHG})$.

$$
I_{OUT(RMS)} = I_{OUT} \times \sqrt{1 + \frac{r}{12}}
$$
\n(6)

where r is the normalized inductor ripple current.

$$
r = V_{OUT} \times (1 - D)/(I_{OUT} \times L \times f_{SW})
$$
 (7)

where:

L is the inductance. f_{SW} is the switching frequency. D is the duty cycle.

$$
D = V_{\text{OUT}}/V_{\text{IN}} \tag{8}
$$

JUNCTION TEMPERATURE

In cases where the ambient temperature, T_A , is known, the thermal resistance parameter, θ_{JA} , can be used to estimate the junction temperature rise. T_J is calculated from T_A and P_D using the formula

$$
T_J = T_A + (P_D \times \theta_{JA})
$$
\n(9)

The typical θ_{JA} value for the 20-bump WLCSP is 46.8°C/W (see [Table 5\)](#page-6-3). A very important factor to consider is that θ_{JA} is based on a 4-layer, 4 in \times 3 in, 2.5 oz copper board as per JEDEC standard, and real applications may use different sizes and layers. It is important to maximize the copper to remove the heat from the device. Copper exposed to air dissipates heat better than copper used in the inner layers.

When designing an application for a particular ambient temperature range, calculate the expecte[d ADP5065](http://www.analog.com/ADP5065) power dissipation (P_D). From this power calculation, the junction temperature, T_J, can be estimated using Equation 9.

Maximum junction temperature (T_J) can also be calculated from the board temperature (T_B) and power dissipation (P_D) using the formula

$$
T_J = T_A + (P_D \times \theta_{JB})
$$
 (10)

where θ_{JB} is the junction-to-board thermal resistance.

The typical value for the 20-bump WLCSP is 9.2°C/W (see [Table 5\)](#page-6-3). θ_{JB} is based on a 4-layer, 4 in \times 3 in, 2.5 oz copper board, as per the JEDEC standard.

For a WLCSP device, where possible, remove heat from every current carrying bump (PGNDx, VINx, SWx, ISO_Sx, and ISO_Bx). For example, thermal vias to the board power planes can be placed close to these pins, where available.

The reliable operation of the charger can be achieved only if the estimated die junction temperature of th[e ADP5065](http://www.analog.com/ADP5065) (Equation 9) is less than 125°C. Reliability and mean time between failures (MTBF) are highly affected by increasing the junction temperature. Additional information about product reliability is available in the ADI Reliability Handbook at the following URL: www.analog.com/reliability_handbook.

FACTORY-PROGRAMMABLE OPTIONS

10-30-2012-A

PACKAGING AND ORDERING INFORMATION

OUTLINE DIMENSIONS

Figure 42. 20-Ball Wafer Level Chip Scale Package [WLCSP] (CB-20-8) Dimensions shown in millimeters

ORDERING GUIDE

 $1 Z =$ RoHS Compliant Part.

NOTES

NOTES

I ²C refers to a communications protocol originally developed by Philips Semiconductors (now NXP Semiconductors).

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D09370-0-2/13(D)

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